


<b>Search Notes</b> 	<b>Application/Control No.</b> 10551839	<b>Applicant(s)/Patent Under Reexamination</b> NOZUE ET AL.
	<b>Examiner</b> Thomas Diaz	<b>Art Unit</b> 4171

SEARCHED			
Class	Subclass	Date	Examiner
74	409,440,44,411,665A,665B,421A,414,446,448	08/06/2008	/TD/
212	253,181	08/06/2008	/TD/
Updated	above.	07/27/2009	/TD/

SEARCH NOTES			
Search Notes		Date	Examiner
Inventor Search done in PALM/eDAN.		08/06/2008	/TD/
Search of US and foreign patents done in EAST.		08/06/2008	/TD/
Consulted with Thomas Brahan, primary in class 212.		08/06/2008	/TD/
Updated Search done.		02/03/2009	/TD/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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